

|  |  |   |                                      |
|--|--|---|--------------------------------------|
| Substitute Form PTO-1449<br>(Modified)   | U.S. Department of Commerce<br>Patent and Trademark Office | Attorney Docket No.<br><b>20228-0013US1</b> | Application No.<br><b>10/580,698</b> |
| <b>Information Disclosure Statement<br/>by Applicant</b><br>(Use several sheets if necessary)<br><br>(37 CFR §1.98(b)) |  | Applicant<br><b>Damian Fiolka et al.</b>    |                                      |
|  |  | Filing Date<br><b>November 29, 2006</b>     | Group Art Unit<br><b>2872</b>        |

| U.S. Patent Documents |           |                 |                  |          |       |          |                            |
|-----------------------|-----------|-----------------|------------------|----------|-------|----------|----------------------------|
| Examiner Initial      | Desig. ID | Document Number | Publication Date | Patentee | Class | Subclass | Filing Date If Appropriate |

| Foreign Patent Documents or Published Foreign Patent Applications |           |                 |                  |                          |       |          |             |
|---|-----------|-----------------|------------------|--------------------------|-------|----------|-------------|
| Examiner Initial  | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation |
|   |           |                 |                  |                          |       |          | Yes No      |

| Other Documents (include Author, Title, Date, and Place of Publication) |           |  |
|---|-----------|--|
| Examiner Initial  | Desig. ID | Document   |
| /J.C./  | 1         | Copy of Chinese Office Action with English translation, for the corresponding Chinese Application No. 201010155323.X, dated <b>December 31, 2011</b> . |
| /J.C./  | 2         | Applied Optics II, Baifukan Co., Ltd., pages 166-167, July 1990.   |

|  |                                      |
|--|--------------------------------------|
| Examiner Signature<br><b>/Jade Chwasz/</b>   | Date Considered<br><b>02/10/2012</b> |
| EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |                                      |